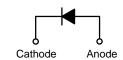


Silicon Carbide (SiC) Schottky Diode - EliteSiC, 30 A, 650 V, D2, D2PAK-2L

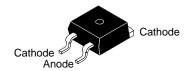
FFSB3065B-F085

Description

Silicon Carbide (SiC) Schottky Diodes use a completely new technology that provides superior switching performance and higher reliability compared to Silicon. No reverse recovery current, temperature independent switching characteristics, and excellent thermal performance sets Silicon Carbide as the next generation of power semiconductor. System benefits include highest efficiency,



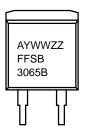
Schottky Diode



faster operating fre**263**e**2Li**) creased power densite tomotive HEVEV DCDC Conv**PA** MARKING DIAGRAM

CASE 418BK

1



A YWW 77 = Assembly Plant Code= Date Code (Year & Week)

= Lot Code

FFSB3065B = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

FFSB3065B-F085

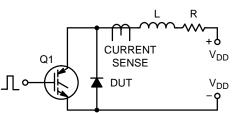
ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{RRM}	Peak Repetitive Reverse Voltage	650	V

FFSB3065B-F085

TEST CIRCUIT AND WAVEFORMS

$$\begin{split} L &= 0.5 \text{ mH} \\ R &< 0.1 \ \Omega \\ V_{DD} &= 50 \ V \\ EAVL &= 1/2 LI2 \left[V_{R(AVL)} \ / \ (V_{R(AVL)} - V_{DD}) \right] \\ Q1 &= IGBT \ (BV_{CES} > DUT \ V_{R(AVL)}) \end{split}$$



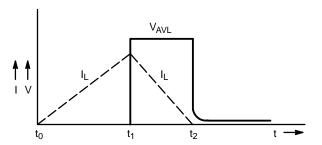


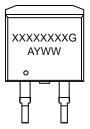
Figure 9. Unclamped Inductive Switching Test Circuit & Waveform

D²PAK2 (TO-263-2L) CASE 418BK ISSUE O

DATE 02 AUG 2018

DET/

GENERIC MARKING DIAGRANI*



XXX = Specific Device Code

A = Assembly Location

= Year

WW = Work Week

G = Pb-Free Package

^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

